

FDZ299P

P-Channel 2.5 V Specified PowerTrench® BGA MOSFET

General Description

Combining Fairchild's advanced 2.5V specified PowerTrench process with state of the art BGA packaging, the FDZ299P minimizes both PCB space and $R_{\rm DS(ON)}$. This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultralow profile packaging, low gate charge, and low $R_{\rm DS(ON)}$.

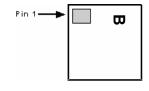
Applications

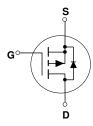
- · Battery management
- Load switch
- Battery protection

Features

- -4.6 A, -20 V $R_{DS(ON)} = 55 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 80 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$
- Occupies only 2.25 mm² of PCB area.
 Less than 50% of the area of a SSOT-6
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Outstanding thermal transfer characteristics:
 4 times better than SSOT-6
- Ultra-low Q_g x R_{DS(ON)} figure-of-merit
- High power and current handling capability.







Bottom Top

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	-4.6	Α
	- Pulsed		-10	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.7	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R_{eJA} Thermal Resistance, Junction-to-Ambient (Note 1a) 72 °C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
В	FDZ299P	7"	8mm	3000 units

	al Characteristics Parameter	T _A = 25°C unless otherwise noted Test Conditions	Min	Tyre	Max	Units
Symbol	Parameter	rest Conditions	IVIIN	Тур	wax	Units
Off Char	acteristics					
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0~V,~I_{D}=-250~\mu\text{A}$	-20			٧
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		-15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			-1	μΑ
I _{GSS}	Gate-Body Leakage.	$V_{GS} = \pm 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250 \mu\text{A}$	-0.6	-1.0	-1.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		3.3		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$\begin{split} V_{GS} = -4.5 \ V, & I_D = -4.6 \ A, \\ V_{GS} = -2.5 \ V, & I_D = -3.6 A, \\ V_{GS} = -4.5 \ V, & I_D = -4.6 \ A, \ T_J = 125 ^{\circ} C \end{split}$		44 68 58	55 80 71	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	-10			Α
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -4.6 \text{ A}$		13		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		742		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		158		pF
C _{rss}	Reverse Transfer Capacitance			77		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		7.8		Ω
Switchin	g Characteristics (Note 2)		•			•
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, \qquad I_D = -1 \text{ A}, \\ V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		9	18	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		9	18	ns
t _{d(off)}	Turn-Off Delay Time			23	37	ns
t _f	Turn-Off Fall Time			14	25	ns
Qg	Total Gate Charge	$V_{DS} = -10V$, $I_D = -4.6 \text{ A}$,		6.6	9	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		1.6		nC
Q_{gd}	Gate-Drain Charge			1.8		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
I _S	Maximum Continuous Drain-Sour				-1.4	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.4 \text{ A} \text{(Note 2)}$		-0.8	-1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = -4.6 \text{ A},$		18		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		6.5		nC

Notes:

^{1.} R_{BJA} is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R_{BJB}, is defined for reference. For R_{BJC}, the thermal reference point for the case is defined as the top surface of the copper chip carrier. R_{BJC} and R_{BJB} are guaranteed by design while R_{BJA} is determined by the user's board design.

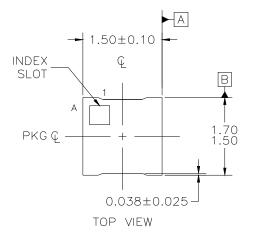


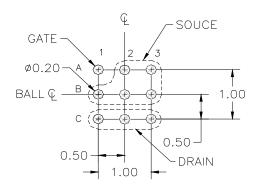
a) 72 °C/W when mounted on a 1in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB



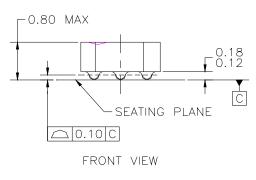
b) 157 °C/W when mounted on a minimum pad of 2 oz copper

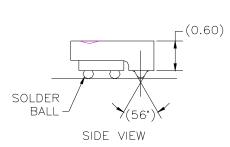
Dimensional Outline and Pad Layout

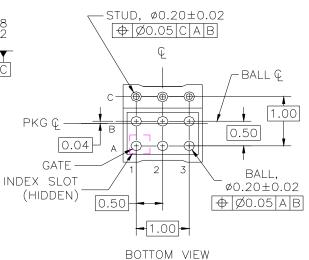




LAND PATTERN RECOMMENDATION







NOTES: UNLESS OTHERWISE SPECIFIED

- A) ALL DIMENSIONS ARE IN MILLIMETERS.
- B) NO JEDEC REGISTRATION REFERENCE AS OF JULY 1999.
- C) BALL/STUD CONFIGURATION TABLE

TERMINAL ID	DESIGNATION	TERMINAL TYPE
C1,C2,C3	DRAIN	COPPER STUD
A1	GATE	BALL
A2,A3,B1,B2,B3	SOURCE	BALL

Typical Characteristics

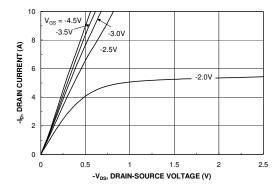


Figure 1. On-Region Characteristics.

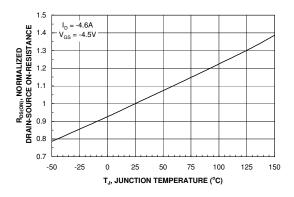


Figure 3. On-Resistance Variation with Temperature.

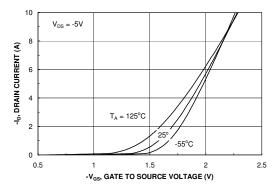


Figure 5. Transfer Characteristics.

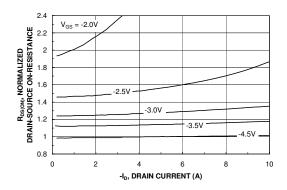


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

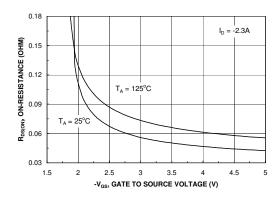


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

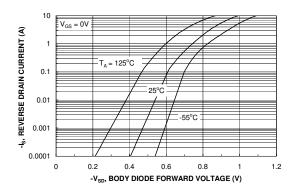
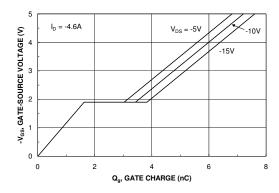


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



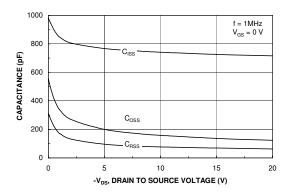


Figure 7. Gate Charge Characteristics.

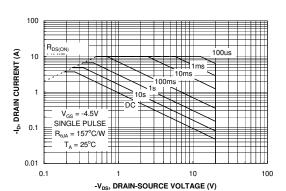


Figure 8. Capacitance Characteristics.

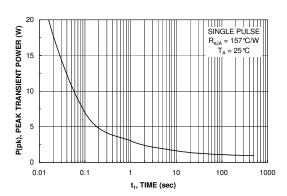


Figure 9. Maximum Safe Operating Area.



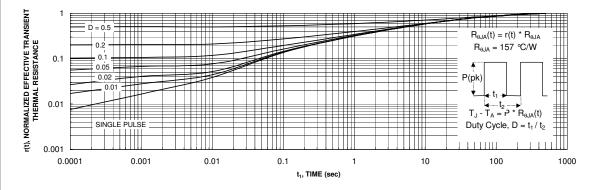


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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CROSSVOLT™	FRFET™	MicroPak™	QS™	SyncFET™
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